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Semiconducting graphene from highly ordered substrate interactions

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While numerous methods have been proposed to produce semiconducting graphene, a significant bandgap has never been demonstrated. The reason is that, regardless of the theoretical gap formation mechanism, sub-nanometer disorder prevents the required symmetry breaking necessary to make graphene semiconducting. In this work, we show for the first time that semiconducting graphene can be made by epitaxial growth. Using improved growth methods, we show by direct band measurements that a bandgap greater than 0.5 eV can be produced in the first graphene layer grown on the SiC(0001) surface. This work demonstrates that order, a property that remains lacking in other graphene systems, is key to producing electronically viable semiconducting graphene.

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It is well known that the first graphene layer grown on the SiC(0001) surface is not electronic graphene. That is, the first “buffer” graphene layer does not show the linear dispersing π -bands (Dirac cone) expected at the K -point of metallic graphene.[1–3] The lack of π -bands in experimental band maps of the buffer layer[2] supported the theoretical conclusion that sufficiently strong covalent bonds between the buffer layer and the SiC interface would push the graphene π -bands below the SiC valence band maximum.[4, 5] Aside from these very early studies, research on the SiC graphene buffer layer faded and was subsequently eclipsed by a wide variety of other unsuccessful ideas to open a bandgap in exfoliated or chemical vapor deposition (CVD)-grown graphene.[6]

One method to open a bandgap in graphene is by periodic bonding to either all A or all B sites, which breaks graphene’s chiral symmetry (referred to as graphene functionalization). The buffer graphene, commensurately bonded to the SiC(0001) surface, should have been an excellent example of a functionalized system. Despite the buffer graphene’s potential to be functionalized by a commensurate and, most importantly, ordered array of Si or C atoms at the SiC surface, there was instead a major research shift to functionalize CVD-grown graphene. As of this writing, no functionalized graphene, or graphene modified by any other proposed method, has been developed that produces a workable semiconducting form of graphene. The problem with these methods is the inherent disorder introduced by the functionalization[7, 8] and growth processes.[6] In fact, the lack of a graphene bandgap was the motivation to shift research to metal dichalcogenides despite the inability to grow them at the level of purity and order required for scalable electronics.

In this work, we use furnace-grown graphene to produce a structurally well ordered buffer graphene (BG) on the SiC(0001) surface. Angle resolved photoemission

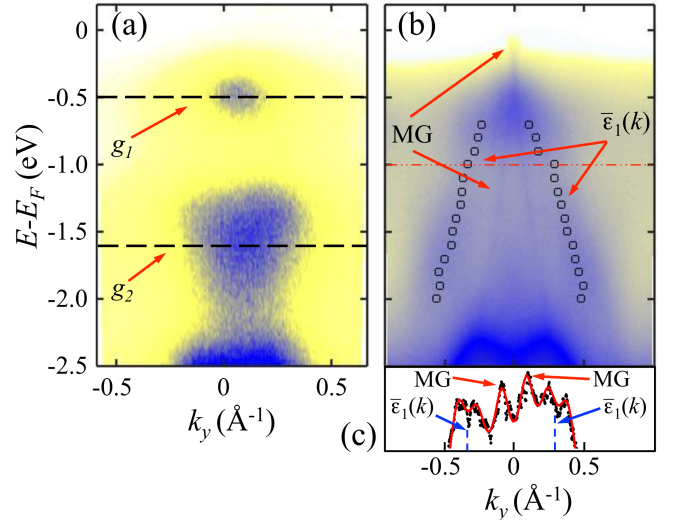


FIG. 1. (a) An ARPES cut through the graphene K -point of an under-grown $6\sqrt{3}$ surface. k_y is perpendicular to $\Gamma - K$ ($\hbar\nu = 36$ eV). The states g_1 and g_2 observed by Emtsev et al. [2] are marked. (b) The same cut as (a) for growth 20°C higher ($\hbar\nu = 70$ eV). Circles mark the peak positions along part of the $\bar{\epsilon}_1$ band. (c) MDC through the bands at 1 eV.

(ARPES) measurements show new dispersing π -bands that are not observed in samples grown by previous methods. These bands live above the SiC valence band maximum near the Fermi Energy, E_F . The new band structure is a result of improved order caused by a higher growth temperature which, for the first time, gives rise to a well ordered 6×6 reconstruction in surface x-ray scattering experiments.[9] The bandgap, which is > 0.5 eV, appears to be the result of the chiral symmetry breaking caused by the 6×6 reconstruction. We demonstrate that the buffer graphene layer on SiC is a true semiconductor,

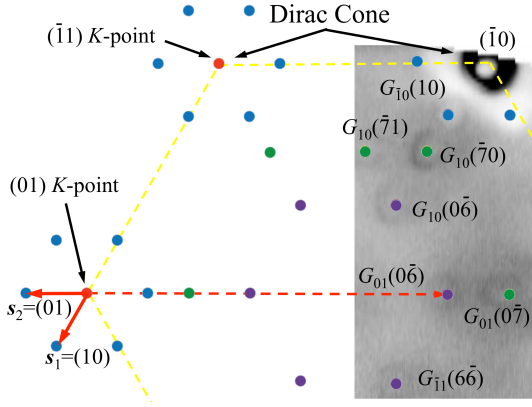


FIG. 2. The right panel is an APRES constant energy cut through part of a ML graphene BZ showing replica cones ($E - E_F = -1$ eV, $h\nu = 36$ eV). Blue dots mark single 6×6 umklapp replicas of the Dirac cones ($\mathbf{s}_1, \mathbf{s}_2$). Umklapp scattered Dirac cones from SiC 1×1 (purple dots) and SiC 1×1 plus 6×6 reciprocal lattice vectors (green dots) are also shown.

the goal of the first graphene electronics research.[10, 11]

ARPES measurements were made at the Cassiopée beamline at the SOLEIL synchrotron. Sample temperature was held at 90K for all experiments. The high resolution Cassiopée beamline is equipped with a modified Peterson PGM monochromator with a resolution $E/\Delta E$ of 25000 for energies below 100 eV. The detector is a Scienta R4000 detector with a base resolution of $\Delta E < 1$ meV. The total energy and momentum resolution were 12 meV and 0.01 \AA^{-1} . E_F was determined to within 20 meV using the intensity cutoff of the molybdenum sample holder and checked against the cutoff energy of the k -integrated $E(k)$ for each sample. The SiC substrates were n-doped CMP polished on-axis 4H-SiC(0001). Graphene was grown in a controlled silicon sublimation furnace.[12] Graphene growth is a function of temperature, time, and crucible geometry that sets the silicon vapor pressure. With the current crucible design, a monolayer (MG) graphene film will grow in 20 min at 1520°C . Using the same crucible, the semiconducting BG discussed in this paper will grow in the same time at a temperature 160°C lower than MG. Growing 20°C lower than the optimum buffer temperature gives the same $(6\sqrt{3} \times 6\sqrt{3})R30^\circ$ LEED pattern (subsequently referred to as $6\sqrt{3}$) as the optimum buffer film but will not show the gapped π -bands discussed below.

Early ARPES work on the UHV-grown $6\sqrt{3}$ reconstructed SiC(0001) surface (referred to as the graphene buffer layer in later literature) found that two non-dispersing states g_1 and g_2 at -0.5 and -1.6 eV were the only band features between E_F and the SiC valence band maximum.[2] These states were interpreted as localized Mott-Hubbard states hybridized from SiC surface dangling bonds. We can reproduce these states by heating the SiC 20°C cooler than the optimal buffer growth tem-

perature. Figure 1(a) shows an ARPES cut through the graphene K -point from this “sub-buffer” film. The previous surface states are clearly visible. However, by heating 20°C higher, a new dispersing band, $\bar{\epsilon}_1(k)$ appears [see Fig. 1(b)]. The new surface state is robust, being reproducible in multiple samples. Note that a faint linear Dirac cone appears at $k_y = 0$. This is due to a small amount of ML graphene ($< 2\%$) that typically nucleates at intrinsic step edges.[13] The Dirac point of the partial monolayer has the typical n-doping (0.55eV below E_F).

Another indication of the improved sample order is the quality of the MG grown above the optimum buffer. Figure 2 shows a constant energy cut through part of the Brillouin Zone (BZ) of a MG film. In addition to the Dirac cone, replicas of the Dirac cone from umklapp scattering processes are also visible. All replica cones from the K^{th} K -point can be indexed using reciprocal lattice vectors of the SiC 6×6 unit cell: $\mathbf{G}_K(m, n) = m\mathbf{s}_1 + n\mathbf{s}_2$, where $|\mathbf{s}_1| = |\mathbf{s}_2| = \frac{1}{6}|\mathbf{a}_{\text{SiC}}^*|$ [see Fig. 2]. In the ordered ML films, replica cones are clearly seen from both 1st-order in the 6×6 unit cell ($\mathbf{s}_1, \mathbf{s}_2$) and from multiple scattering processes involving 1st-order ($\mathbf{s}_1, \mathbf{s}_2$) plus a SiC \mathbf{G} vector (e.g., the $\mathbf{G}_K(\bar{7}, 0)$ and $\mathbf{G}_K(\bar{7}, 1)$). Early UHV grown samples only showed 1st-order replicas (i.e., $n, m = 1$).[14] The fact that so many ARPES replicas bands are observed in these films, along with the 6th order x-ray diffraction rods,[9] testifies to the film’s improved order.

Detailed ARPES measurements from these improved samples show a gapped set of π -band bands. A momentum distribution curve (MDC) through the π -band [Fig. 1(c)] shows 3 sets of bands: one set from the partial ML and a split pair of bands $\bar{\epsilon}_1(k)$. Even though the split bands have a Δk width that is only 12% wider than the ML bands, their splitting ($< 0.13 \text{ \AA}^{-1}$) and the background level makes them difficult to resolve. In this work we will refer to these bands by their average dispersion $\bar{\epsilon}_1(k)$. More detailed studies of these bands will be presented in a future work. Figure 3(a) shows a constant energy cut through part of the BZ of a buffer layer graphene near the $\bar{\epsilon}_1(k)$ band maximum. Three lobes are visible that represent a second dispersing band, $\epsilon_2(k)$, that is marked in the $\Gamma KM'$ cut in Fig. 3(b) and (c). Again, a Dirac cone from a small amount of MG is visible. The two bands are independent of the perpendicular momentum $k_\perp(E)$ and therefore cannot be due to bulk bands. The tops of both bands lie $\Delta E \sim 0.5$ eV below E_F , or 1.8 eV above the valence band maximum of SiC interface, indicating that the MG is semiconducting graphene with a bandgap suitable for real electronics application. A schematic of the two bands is shown in Fig. 4. The $\bar{\epsilon}_1(k)$ band appears as a gapped π -band that disperses slower perpendicular to ΓK than along either ΓK or KM [see Table I]. The linear part of $\bar{\epsilon}_1(k)$ has a velocity, v , that is significantly lower than the Fermi velocity, v_F , reducing to nearly half v_F perpendicular to ΓK [see Table I].

The $\epsilon_2(k)$ band is 3-fold symmetric, extending towards

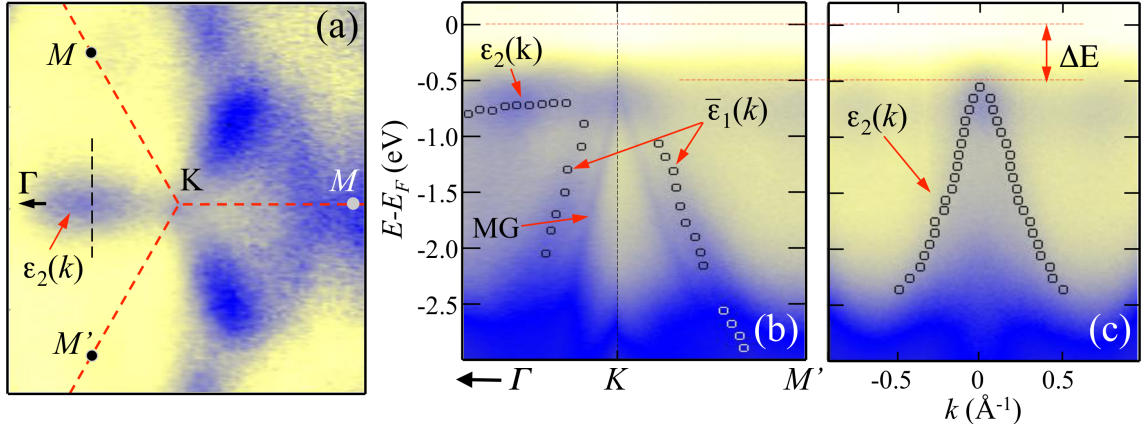


FIG. 3. (a) A constant energy cut through the graphene BZ near the K-point ($E - E_F = -0.41\text{eV}$, $h\nu = 70\text{eV}$). Dashed lines mark the BZ boundary. (b) A cut through the surface bands in the $\Gamma K M'$ direction. Circles mark the peak positions along with a few higher binding energy bands. A Dirac cone from a partial ML is shown. (c) A cut perpendicular to ΓK through the ϵ_2 band [vertical black dashed line in (a)]. Circles mark the peak positions of the ϵ_2 band.

TABLE I. Band velocity and effective mass (m^*) near the π -band maximum. m^* is estimated assuming parabolic bands.

Band	v/v_F	m^*/m_e
ML Dirac cone	1.0	-
$\bar{\epsilon}_1$ ($\perp \Gamma K$)	0.55 ± 0.01	1.0 ± 0.02
$\bar{\epsilon}_1$ (ΓK)	0.63 ± 0.1	1.5 ± 0.5
$\bar{\epsilon}_1$ ($K M$)	0.80 ± 0.1	0.55 ± 0.05
ϵ_2 ($\perp \Gamma K$)	0.98 ± 0.07	0.25 ± 0.02
ϵ_2 (ΓK)	$\gtrsim 10^{-3}$	1.5 ± 0.1

Γ and dispersing perpendicular to ΓK . Figure 3(c) shows a cut perpendicular through the lobe in Fig. 3(a). The band velocity of $\epsilon_2(k)$ perpendicular to ΓK is nearly the same as monolayer graphene [see Table I]. The $\bar{\epsilon}_1$ band has an effective mass (m^*) that ranges between 0.55 to $1.5m_e$, while ϵ_2 is a light band perpendicular to ΓK but has a smaller dispersion (larger m^*) along ΓK .

In a broad sense, the gapped band structure strongly suggests chiral symmetry breaking that mixes the π bands from the K and K' points.[15] Any periodic potentials that break the AB symmetry in the graphene through bond formation, chemical or strain fields, or finite size effects can open a gap. Weak interactions like those in bilayer graphene only produce small gaps.[16] The strain necessary to open the observed bandgaps by Kekule distortions[17] would also be large enough to tear the graphene,[18] inconsistent with the 0.7% strain measured by X-ray scattering.[9, 19] Periodic bonding of the BG to the underlying substrate remains the most likely source of the chiral symmetry breaking.

A theoretical understanding of the BG layer, and therefore an understanding of the origin of the observed gap, is difficult because of the excessive calculation time associated with exploring different models for the large

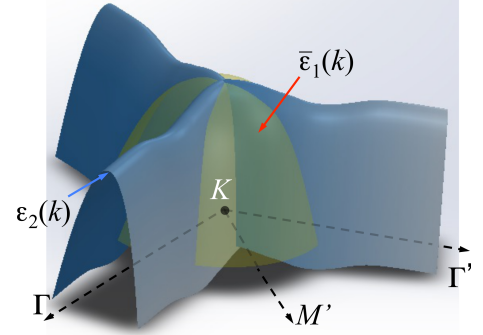


FIG. 4. A schematic of the $\bar{\epsilon}_1(k)$ and $\epsilon_2(k)$ buffer layer bands near the top of the π -bands around the K-point.

$6\sqrt{3}$ unit cell. Rather than calculating the full cell, early calculations instead used a strained $\sqrt{3} \times \sqrt{3}$ R30 SiC reconstruction to make calculations more tractable.[4, 5] These calculations predicted that strong sp^3 bonds between 2/3 of the interfacial Si atoms and the buffer buffer graphene caused the π -bands to shift above and below the conduction band minimum and valence band maximum, respectively. The calculations also predicted a metallic, slightly delocalized, surface state near E_F due to unbounded Si atoms in the interface, similar to the states observed experimentally in the earlier, less ordered samples like in Fig. 1(a).[2] These approximate models are clearly insufficient to explain the observed bands. Only one *ab initio* calculation by Kim et al.[20] has calculated the band structure for the buffer using a full $6\sqrt{3}$ cell. While the calculation was restricted to a bulk terminated interface,[20] it does give some insight into the origin of the observed gap when compared to the ARPES results.

Kim et al.[20] find that about 25% of the carbon atoms in the buffer graphene are covalently bonded to

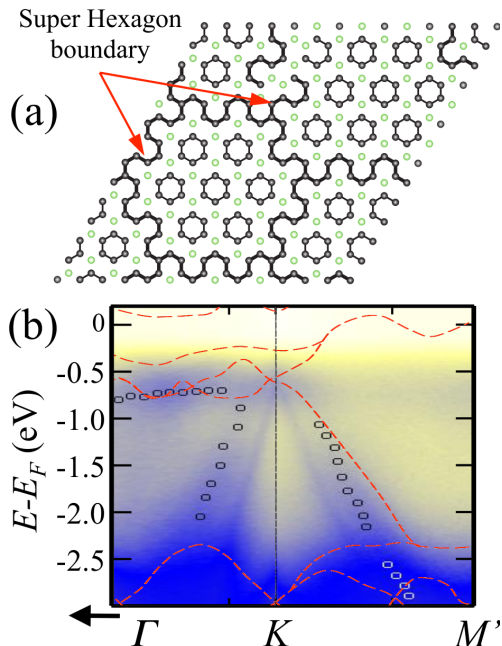


FIG. 5. (a) The calculated BG layer ($6\sqrt{3} \times 6\sqrt{3}$)R30° cell on a relaxed SiC(0001) surface.[20] Green circles are buffer carbon atoms bonded to the SiC surface. Black circles are unbounded carbon. Chains of unbounded atoms define superhexagonal regions. (b) The calculated bands (dashed lines) from the structure in (a) overlaid on the ARPES bands. The theoretical bands are shifted -0.13 eV to match the ϵ_2 band.

Si atoms on the SiC interface. The resulting structure is a hexagonal network of graphene ribbon-like structures with the remaining buffer carbon atoms covalently bonded to the SiC surface [see Fig. 5(a)]. Similar hexagonal networks, either structural or electronic, have been observed in Scanning Tunneling Microscopy or produced theoretically.[21–23] The DFT calculations show that the π -orbitals of carbon atoms on the superhexagonal boundaries give rise to several bands near the K -point above and below E_F . These bands are overlaid on our measured bands in Fig. 5(b). Like the experimental $\bar{\epsilon}_1(k)$ and $\epsilon_2(k)$ bands, the theoretical model shows that the covalent bonding to the SiC does not completely destroy the π -bands as earlier calculations predicted. Nonetheless, the calculations do not reproduce several important experimental features. The calculations do not predict the formation of a bandgap nor do they correctly reproduce the $\bar{\epsilon}_1$ dispersion, especially from Γ to K .

We suggest that while the model of Kim et al.[20] does not produce a bandgap, there are features in the calculated structure that may lead to a bandgap once a correct substrate interaction is taken into account. The large amount of covalent bonds associated with a bulk terminated SiC used in the calculation likely over estimates the graphene-SiC interaction. It is more likely that the buffer graphene is bonded to the SiC through a smaller number of sites consistent with STM measurements that

suggest the buffer lies above a small set of Si-trimers.[24] A reduced buffer-SiC bonding geometry is also consistent with both x-ray scattering[25] and x-ray standing wave experiments,[26] which find a reduced Si-concentration and an increased C-concentration in the SiC layer below the buffer. We suggest that the reduced substrate bonding would still be sufficient to strain the buffer and produce the ribbon network. In fact the ribbon network is the only structural part of the calculation that has been confirmed experimentally by STM.[22] However, the experimental width of the ribbons is about twice as wide as Kim et al.[20] predicts. We postulate that the part of the buffer that is bonded to the SiC is so altered by the interaction that it becomes electronically decoupled from the ribbons. The ribbon network would now be isolated from the substrate and could give rise to a connected hexagonal graphene ribbon-network instead of the linear chain of carbon atoms predicted in the model. The narrow ribbons would have a bandgap due to the finite size effect.[27] Given the narrow ribbon width, finite size gaps are consistent with the size of the bandgap we measure.

In this work we show that, despite claims to the contrary, a semiconducting form of graphene can be manufactured. Using improved growth methods, we have been able to produce a well ordered single layer of graphene on the SiC(0001) surface. The first graphene layer, known as the buffer layer, is a semiconducting form of graphene. Using ARPES, we show that the improved sample order leads to new bands with a band maximum that lies $\Delta E \sim 0.5$ eV below the Fermi Level. Depending on where the conduction band lies, the bandgap of this form of graphene must be > 0.5 eV. While no theoretical model predicts the measured bands, the experimental bands resemble those from a network of graphene ribbons that are distortions in the buffer layer. The distortions would be due to strain relief caused by a subset of carbon atoms in the buffer that locally bond to the SiC surface.

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